

Notice of References Cited	Application/Control No. 10/686,560	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Kan Yuen	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0031639 A1	10-2001	Makipaa, Risto	455/450
*	B	US-2001/0028637 A1	10-2001	Abeta et al.	370/335
*	C	US-2002/0172160 A1	11-2002	Moulsley, Timothy J.	370/252
*	D	US-2003/0031121 A1	02-2003	Sudo, Hiroaki	370/203
*	F	US-2003/0081538 A1	05-2003	Walton et al.	370/206
*	F	US-2003/0165131 A1	09-2003	Liang et al.	370/342
*	G	US-2004/0037214 A1	02-2004	Blasco Claret et al.	370/203
*	H	US-2004/0028021 A1	02-2004	Varshney et al.	370/342
*	I	US-7,151,937 B2	12-2006	Jin et al.	455/450
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.